confirmation no. 5057

Applicant Feng Chen Attorney Docket: CS03-039

Submission with RCE and Response to Advisory action dated 2006-12-14

AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions, and listing, of claims in the application:

Listing of claims:

groove;

Claims 1-36 (CANCELED)

37. (CURRENTLY AMENDED) A CMP retaining ring, comprising:

an inner peripheral surface;

an outer peripheral surface;

a lower surface adapted to contact and depress an upper surface of a polishing pad during chemical mechanical polishing of a lower <u>substrate</u> surface of a substrate;

a plurality of grooves on said lower surface of said <u>CMP</u> retaining ring; <u>each</u> groove of said plurality of grooves <u>continuously extends entirely across said lower surface</u> extending from said inner peripheral surface to said outer peripheral surface;

said plurality of grooves are spaced apart;

said plurality of grooves include includes at least a first groove and a second

at least a portion of said first groove <u>not adjacent to the lower surface</u> has a rounded cross sectional <u>cross-sectional</u> contour <u>along substantially the entire length of said first groove</u> or slanted cross sectional contour.

- 38. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said lower surface of said retaining CMP ring is essentially flat with only said plurality of grooves therein.
- 39. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said plurality of grooves do not intersect; said plurality of grooves do not communicate with each other; each groove of said plurality of grooves only communicates emmunicate between said inner peripheral surface and said outer peripheral surface; said first groove forms a first inner

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peripheral surface opening in the inner peripheral surface and a first outer peripheral surface opening in the outer peripheral surface.

40. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said plurality of grooves are linear; and

<u>each groove of</u> said plurality of grooves <u>are is</u> uninterrupted extending <u>continuously the entire</u> <u>distance</u> from said inner peripheral surface to said outer peripheral surface; <u>and</u> said lower surface does not comprise an annular recess.

- 41. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove has a semicircle cross-sectional profile along said first groove's entire length; and wherein said second groove has a semicircle profile along substantially the entire length of said second groove; each groove of the plurality of grooves communicates between the inner peripheral surface and the outer peripheral surface.
- 42. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein each groove of said plurality of grooves has have a semicircle cross-sectional profile along substantially [[the]] their entire length extending continuously in said lower surface the entire distance from said inner peripheral surface to said outer peripheral surface.
- 43. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove has a semicircle <u>cross-sectional</u> profile and said first groove has a rounded top corner adjacent to the lower surface of the <u>CMP</u> retaining ring.
- 44. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove has a semicircle <u>cross-sectional</u> profile; <u>with a radius between 2 and 15 mm</u>

said first groove has a rounded top corner adjacent to the lower surface of the CMP retaining ring; and each groove of said plurality of grooves is linear.

45. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove is comprised of: sidewalls, a flat horizontal bottom, and rounded bottom corners between said

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sidewalls and said flat horizontal bottom; and

said first groove has curved sidewalls with a curved cross-sectional eross sectional shape.

46. (PREVIOUSLY PRESENTED) The CMP retaining ring of claim 37 wherein said first groove has rounded corners adjacent to a bottom of said first groove.

- 47. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove has rounded top corners adjacent to the lower surface of said CMP retaining ring.
- 48. (CURRENTLY AMENDED) The CMP retaining ring of claim 37 wherein said first groove has vertical sidewalls, [[and]] an about horizontal bottom and at least one rounded corner between said <u>vertical</u> sidewalls and said horizontal bottom; and <u>said first groove having</u> rounded top corners near the lower surface of said <u>CMP retaining</u> ring.
- 49. (PREVIOUSLY PRESENTED) The CMP retaining ring of claim 37 wherein said first groove has straight sidewalls, top corners, bottom corners, [[;]] and an about horizontal bottom; [[,]] said bottom corners are rounded or curvilinear; and said bottom corners are adjacent to said horizontal bottom and said straight sidewalls.

50. (CURRENTLY AMENDED) A CMP retaining ring, comprising:

an inner peripheral surface;

an outer peripheral surface;

a lower surface adapted to contact and depress an upper surface of a polishing pad during chemical mechanical polishing of a lower <u>substrate</u> surface of a substrate;

a plurality of grooves on said lower surface of said <u>CMP</u> retaining ring;

[[and]] <u>each groove of said plurality of grooves continuously extends extending an entire distance</u> from said inner peripheral surface of said <u>CMP</u> retaining ring[[,]] to said outer peripheral surface of said <u>CMP</u> retaining ring; <u>said first groove forms a first inner peripheral surface opening in the inner peripheral surface and a first outer peripheral surface opening in the outer peripheral surface;</u>

each groove of said plurality of grooves communicates between said inner peripheral surface and said outer peripheral surface;

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said plurality of grooves are spaced apart; said plurality of grooves only communicate between said inner peripheral surface and said outer peripheral surface;

said plurality of grooves <u>includes</u> at least a first groove and a second groove; <u>and</u>

at least a portion of said first groove <u>not adjacent to the lower surface</u> has a rounded cross sectional <u>cross-sectional</u> contour <u>along substantially the entire length of the first groove or slanted cross sectional contour</u>.

- 51. (CURRENTLY AMENDED) The CMP retaining ring of claim 50 wherein <u>each groove of</u> said plurality of grooves are is uninterrupted <u>continuously</u> extending from said inner peripheral surface to said outer peripheral surface; <u>and</u> said lower surface does not comprise an annular recess.
- 52. (CURRENTLY AMENDED) The CMP retaining ring of claim 50 wherein said first groove has a semicircle cross-sectional profile along the entire length of said first groove; and said second groove has a semicircle cross-sectional profile along the entire length of said second groove.
- 53. (CURRENTLY AMENDED) The CMP retaining ring of claim 50 wherein said first groove has a semicircle cross-sectional profile and said first groove has a rounded top corner adjacent to the lower surface of the CMP retaining ring.
- 54. (CURRENTLY AMENDED) The CMP retaining ring of claim 50 wherein said first groove has a semicircle <u>cross-sectional</u> profile[[.]];

said plurality of grooves are linear; and

<u>each groove of</u> said plurality of grooves <u>are is</u> uninterrupted extending from said inner peripheral surface to said outer peripheral surface;

at least a portion of said second groove not adjacent to the lower surface has a rounded cross-sectional contour extending substantially the entire length of the second groove; and said lower surface does not comprise an annular recess.

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55. (CURRENTLY AMENDED) A process for chemical-mechanical polishing a substrate comprising:

[[said]] <u>providing a substrate</u> [[is]] disposed within a polishing head facing a polishing table; said substrate is retained within the polishing head by a <u>retainer retaining</u> ring, and

said retaining ring is comprised of:

an inner peripheral surface;

an outer peripheral surface;

a lower surface adapted to contact and depress an upper surface of a polishing pad during chemical mechanical polishing of a lower <u>substrate</u> surface of the substrate;

a plurality of grooves on said lower surface of said retaining ring; <u>each</u> groove of said plurality of grooves <u>continuously extends entirely across said lower surface</u> extending from said inner peripheral surface of said retaining ring to said outer peripheral surface of said retaining ring; <u>each groove of said plurality of grooves communicates between said inner peripheral surface</u> and said outer peripheral surface;

said plurality of grooves are spaced apart;

said plurality of grooves only communicate between said inner peripheral surface and said outer peripheral surface;

said plurality of grooves <u>includes</u> include at least a first groove and a second groove;

at least a portion of said first groove <u>not adjacent to said lower surface</u> has a rounded <u>cross-sectional</u> contour <u>along substantially the entire length of said first groove</u>; or slanted cross sectional contour;

supplying a slurry to said polishing table or to said polish head; <u>and</u> moving the polishing table and/or the polishing head to chemically polish the substrate.

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56. (CURRENTLY AMENDED) The process of claim 55 which further includes: said substrate is a wafer; forming a deposition layer on the surface of said wafer; and chemical mechanically polishing said deposition layer.

57. (CURRENTLY AMENDED) The process of claim 55 wherein said first groove has a semicircle <u>cross-sectional</u> profile along <u>substantially</u> the entire length <u>of said first groove</u> extending <u>continuously</u> the <u>entire distance</u> from said inner peripheral surface to said outer peripheral surface; and

said first groove forms a first inner peripheral surface opening in the inner peripheral surface and a first outer peripheral surface opening in the outer peripheral surface.

- 58. (CURRENTLY AMENDED) The process of claim 55 wherein said first groove has a semicircle <u>cross-sectional</u> profile and said first groove has a rounded corner adjacent to the lower surface of the retaining ring.
- 59. (CURRENTLY AMENDED) The process of claim 55 wherein <u>each groove of said</u> plurality of grooves <u>are is</u> uninterrupted extending <u>continuously</u> from said inner peripheral surface to said outer peripheral surface;

said lower surface does not comprise an annular recess;

said first groove has a semicircle profile along substantially an entire length of said first groove extending continuously the entire distance from said inner peripheral surface to said outer peripheral surface; said first groove forms a first inner peripheral surface opening in the inner peripheral surface and a first outer peripheral surface opening in the outer peripheral surface;

said first groove has a semicircle cross-sectional profile and said first groove has a rounded corner adjacent to the lower surface of the retaining; and said plurality of grooves are linear.

60. (CURRENTLY AMENDED) The process of claim 55 wherein said first groove has rounded edges adjacent to [[the]] a bottom of said first groove.

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61. (PREVIOUSLY PRESENTED) The process of claim 55 wherein said first groove has rounded top edges adjacent to the lower surface of said retaining ring.